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<u>MOSFET</u> – POWERTRENCH^{®,} 20 V Complementary

N-Channel: 20 V, 3.7 A, 68 m Ω P-Channel: -20 V, -3.1 A, 95 m Ω

FDMA1032CZ

General Description

This device is designed specifically as a single package solution for a DC/DC "Switching" MOSFET in cellular handset and other ultra-portable applications. It features an independent N-Channel & P-Channel MOSFET with low on-state resistance for minimum conduction losses. The gate charge of each MOSFET is also minimized to allow high frequency switching directly from the controlling device. The MicroFET^M 2x2 package offers exceptional thermal performance for its physical size and is well suited to switching applications.

Features

Q1: N-Channel

- $R_{DS(on)} = 68 \text{ m}\Omega \text{ at } V_{GS} = 4.5 \text{ V}$
- $R_{DS(on)} = 86 \text{ m}\Omega$ at $V_{GS} = 2.5 \text{ V}$ Q2: P-Channel
- Q_2 . F = Channel
- $R_{DS(on)} = 95 \text{ m}\Omega \text{ at } V_{GS} = -4.5 \text{ V}$
- $R_{DS(on)} = 141 \text{ m}\Omega \text{ at } V_{GS} = -2.5 \text{ V}$
- Low Profile 0.8 mm Maximum In the New Package MicroFET 2x2 mm
- HBM ESD Protection Level > 2 kV (Note 3)
- Free from Halogenated Compounds and Antimony Oxides
- This Device is Pb-Free, Halide Free and is RoHS Compliant



V _{DS} MAX	R _{DS(on)}	I _D MAX
20 V	68 mΩ @ 4.5 V	3.7 A
	86 mΩ @ 2.5 V	

P-Channel

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V _{DS} MAX	R _{DS(on)}	I _D MAX				
–20 V	95 mΩ @ –4.5 V	–3.1 A				
	141 mΩ @ –2.5 V					



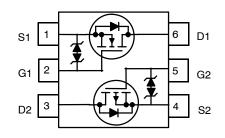
WDFN6 2x2, 0.65P (MicroFET) CASE 511DA

MARKING DIAGRAM



- &Z = Assembly Plant Code
- &2 = 2-Digit Date Code
- &K = 2-Digits Lot Run Traceability Code
- 032 = Device Code

PIN CONNECTIONS



ORDERING INFORMATION

Device	Package	Shipping [†]
FDMA1032CZ	WDFN6 (Pb-Free, Halide Free)	3000 / Tape & Reel

For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parar	neter	Q1	Q2	Unit
V _{DS}	Drain-Source Voltage		20	-20	V
V _{GS}	Gate-Source Voltage		±12	±12	V
I _D	Drain Current	Continuous (Note 1a)	3.7	-3.1	А
		Pulsed	6	-6	
PD	Power Dissipation for Single Operation	(Note 1a)	1	1.4	
		(Note 1b)	().7	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		–55 t	o +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	86 (Single Operation)	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	173 (Single Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1c)	69 (Dual Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1d)	151 (Dual Operation)	

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Unit	
OFF CHAR	OFF CHARACTERISTICS							
BV _{DSS}	Drain-Source Breakdown Voltage	$ I_D = 250 \; \mu A, \; V_{GS} = 0 \; V \\ I_D = -250 \; \mu A, \; V_{GS} = 0 \; V $	Q1 Q2	20 -20	-	-	V	
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25°C I_D = -250 µA, referenced to 25°C	Q1 Q2	-	15 -12	-	mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	Q1 Q2	-	-	1 _1	μΑ	
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 12$ V, $V_{DS} = 0$ V	All	-	-	±10	μΑ	

ON CHARACTERISTICS (Note 2)

V _{GS(th)}	Gate Threshold Voltage	$\begin{array}{l} I_D = 250 \ \mu\text{A}, \ V_{DS} = V_{GS} \\ I_D = -250 \ \mu\text{A}, \ V_{DS} = V_{GS} \end{array}$	Q1 Q2	0.6 0.6	1.0 –1.0	1.5 –1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25°C $I_D = -250 \ \mu$ A, referenced to 25°C	Q1 Q2	1 1	-4 4		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	$ \begin{array}{l} V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3.7 \text{ A} \\ V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 3.3 \text{ A} \\ V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3.7 \text{ A}, \text{ T}_{J} = 125^{\circ}\text{C} \end{array} $	Q1		37 50 53	68 86 90	mΩ
		$ \begin{array}{l} V_{GS}=-4.5 \text{ V}, \text{ I}_{D}=-3.1 \text{ A} \\ V_{GS}=-2.5 \text{ V}, \text{ I}_{D}=-2.5 \text{ A} \\ V_{GS}=-4.5 \text{ V}, \text{ I}_{D}=-3.1 \text{ A}, \text{ T}_{J}=125^{\circ}\text{C} \end{array} $	Q2	- - -	60 88 87	95 141 140	
9 _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 3.7 \text{ A}$ $V_{DS} = -10 \text{ V}, \text{ I}_{D} = -3.1 \text{ A}$	Q1 Q2		16 _11	-	S

DYNAMIC CHARACTERISTICS

C _{iss}	Input Capacitance	Q1 V _{DS} = 10 V, V _{GS} = 0 V, f = 1.0 MHz	Q1 Q2	-	340 540	-	pF
C _{oss}	Output Capacitance	Q2 V _{DS} = -10 V, V _{GS} = 0 V, f = 1.0 MHz	Q1 Q2	-	80 120	-	pF
C _{rss}	Reverse Transfer Capacitance		Q1 Q2	-	60 100	-	pF

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Unit
SWITCHING	G CHARACTERISTICS (Note 2)						
t _{d(on)}	Turn-On Delay Time	Q1 $V_{DD} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ A}$	Q1 Q2	-	8 13	16 24	ns
t _r	Turn–On Rise Time	$V_{GS} = 4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2	-	8 11	16 20	ns
t _{d(off)}	Turn-Off Delay Time	V_{DD} = -10 V, I _D = -1 A V_{GS} = -4.5 V, R _{GEN} = 6 Ω	Q1 Q2	-	14 37	26 59	ns
t _f	Turn-Off Fall Time		Q1 Q2	-	3 36	6 58	ns
Qg	Total Gate Charge	Q1 V_{DS} = 10 V, I _D = 3.7 A, V _{GS} = 4.5 V	Q1 Q2		4 7	6 10	nC
Q _{gs}	Gate-Source Charge	Q2 $V_{DS} = -10 \text{ V}, \text{ I}_{D} = -3.1 \text{ A}, \text{ V}_{GS} = -4.5 \text{ V}$	Q1 Q2	-	0.7 1.1	-	nC
Q _{gd}	Gate-Drain Charge		Q1 Q2	-	1.1 2.4		nC

DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

١ _S	Maximum Continuous Source-Drain Diode Forward Current		Q1 Q2	-	-	1.1 -1.1	A
V _{SD}	Source-Drain Diode Forward Voltage	V_{GS} = 0 V, I _S = 1.1 A (Note 2) V_{GS} = 0 V, I _S = -1.1 A (Note 2)	Q1 Q2	-	0.7 0.8	1.2 –1.2	V
t _{rr}	Diode Reverse Recovery Time	Q1 I _F = 3.7 A, dI _F /dt = 100 A/µs	Q1 Q2	-	11 25	-	ns
Q _{rr}	Diode Reverse Recovery Charge	Q2 I _F = –3.1 A, dI _F /dt = 100 A/µs	Q1 Q2	-	2 9	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 1. R_{0JA} is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design

while $R_{\theta JA}$ is determined by the user's board design.

a. $R_{\theta JA} = 86^{\circ}C/W$ when mounted on a 1 in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB. For single operation.

b. $R_{\theta JA} = 173^{\circ}C/W$ when mounted on a minimum pad of 2 oz copper. For single operation.

c. $R_{0JA} = 69^{\circ}C/W$ when mounted on a 1 in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB. For dual operation.

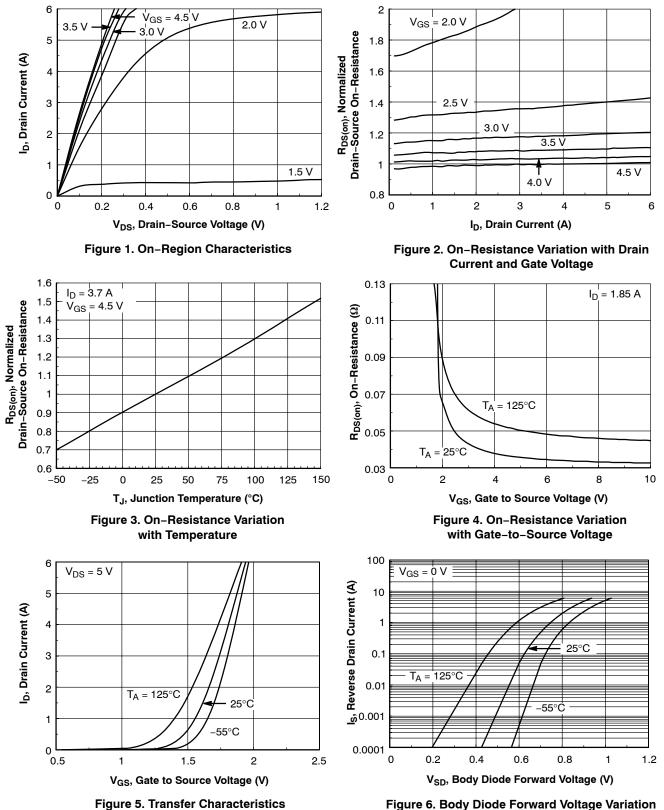
d. $R_{\theta JA} = 151^{\circ}C/W$ when mounted on a minimum pad of 2 oz copper. For dual operation.



2. Pulse Test: Pulse Width < 300 µs, Duty Cycle < 2.0%

3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

TYPICAL CHARACTERISTICS Q1 (N-Channel)



gure 6. Body Diode Forward Voltage Variatio with Source Current and Temperature

TYPICAL CHARACTERISTICS Q1 (N-Channel) (continued)

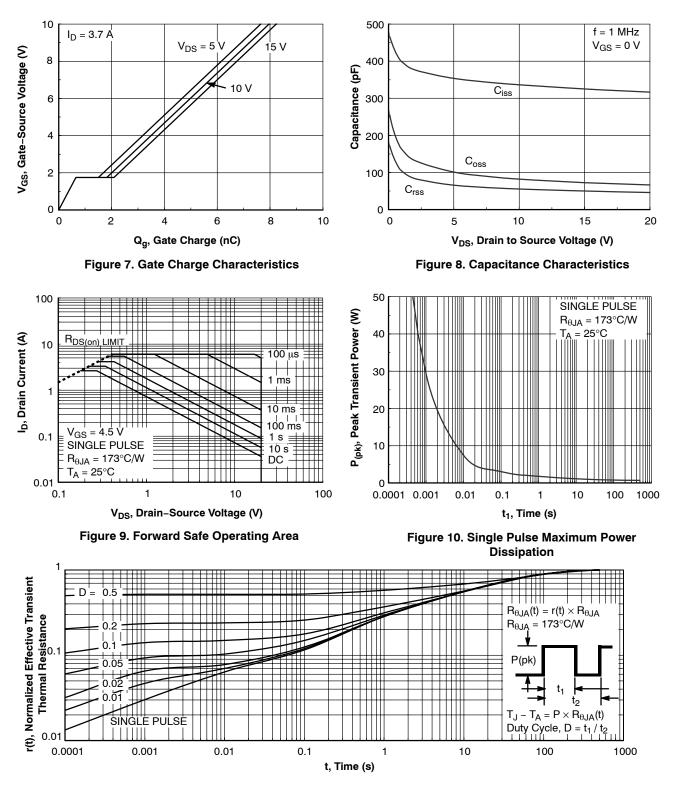
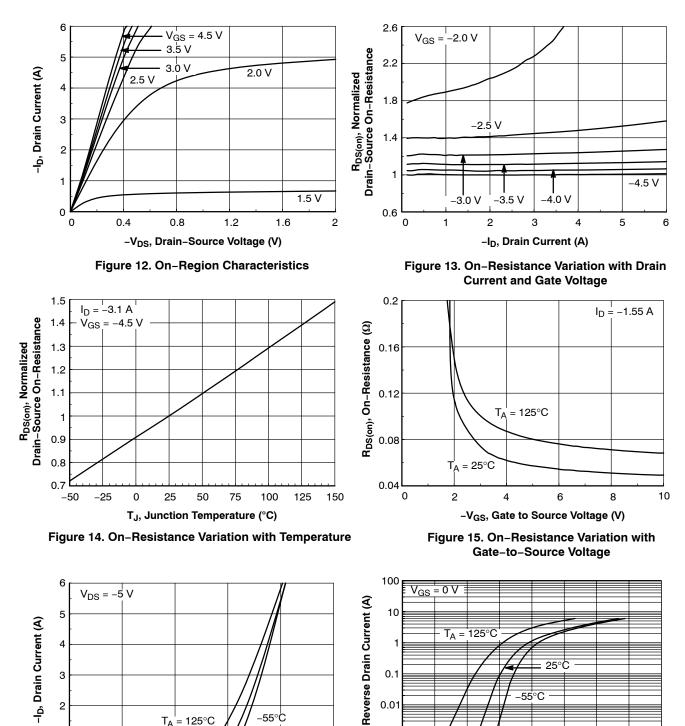


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

TYPICAL CHARACTERISTICS Q2 (P-Channel)



2.5

–55°Ċ

2

25°C

1.5

-V_{GS}, Gate to Source Voltage (V)

Figure 16. Transfer Characteristics

T_A = 125°C

1

0.01

0.001 ف

0.0001

0

0.2

0.4

0.6

2

1

0

0

0.5

-55[°]C

0.8

-V_{SD}, Body Diode Forward Voltage (V)

Figure 17. Body Diode Forward Voltage Variation with Source Current and Temperature

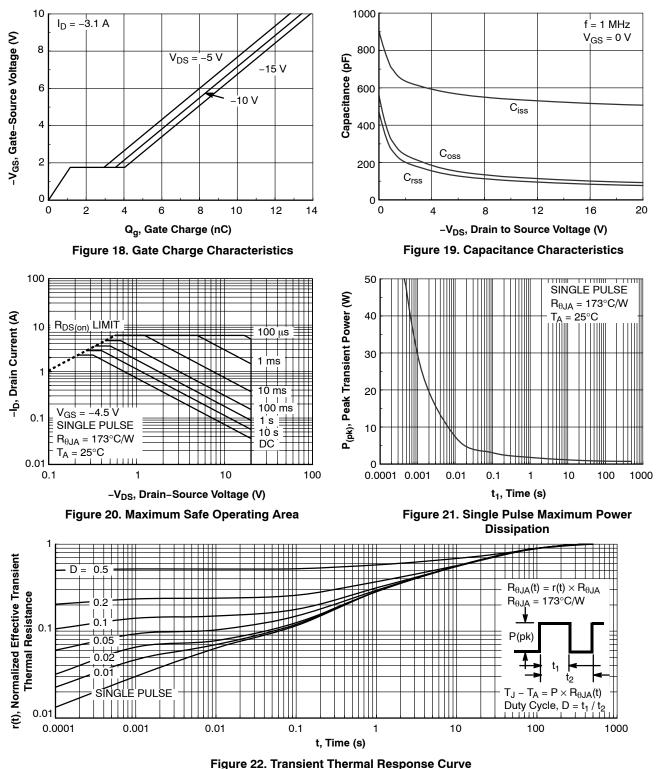
1

1.2

1.4

1.6

TYPICAL CHARACTERISTICS Q2 (P-Channel) (continued)



Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

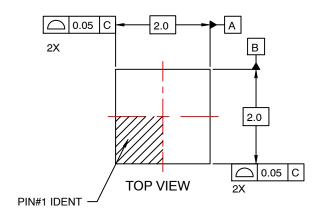
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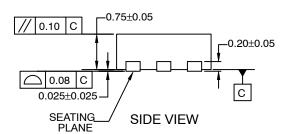
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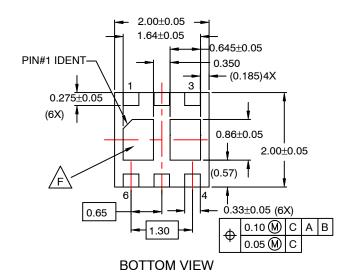


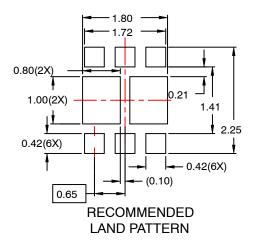
WDFN6 2x2, 0.65P CASE 511DA ISSUE O

DATE 31 JUL 2016









NOTES:

- A. CONFORM TO JADEC REGISTRATIONS MO-229, VARIATION VCCC, EXCEPT WHERE NOTED.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.



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